

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/571,477	TATTUM ET AL.	
		Examiner	Art Unit	Page 1 of 1
		Tae H. Yoon	1796	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,637,957	01-1987	Murase, Shigemitsu	428/395
*	B	US-4,965,301	10-1990	Leininger, James C.	524/101
*	C	US-5,164,436	11-1992	Maier et al.	524/290
*	D	US-6,068,910	05-2000	Flynn et al.	428/141
*	E	US-6,740,697	05-2004	Brenner et al.	524/166
*	F	US-7,220,815	05-2007	Hayes, Richard Allen	528/272
G	US-				
H	US-				
I	US-				
J	US-				
K	US-				
L	US-				
M	US-				

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	I					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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